Energy Recovery Linac & Ultimate Light Source Overview



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- Need for better x-ray sources
- PEP-X as example of ULS
- Cornell ERL as example of ERL
- Example experiments that can use the unique properties of an ULS or ERL



Starting Perspective of 3rd Generation Storage Ring Developer/User



My experiment could use:

- Higher spectral brightness
- More x-ray flux
- Shorter pulse length
- More coherent x-rays
- etc.



Can quantify the need for better SR beams still further!

Some user answers:

A lot of photons into a small spot A lot of coherent photons A lot of photons in a short pulse A high pulse repetition rate Not too many photons Femtosecond pump-probe timing stability 0.1% intensity stability 50 keV photons 10⁻⁶ energy bandwidth (meV) fast switched polarization

A lot of photons into a large area A high coherent fraction A lot of photons in a long pulse A low pulse repetition rate nm spatial resolution 280 eV photons 10⁻² energy bandwidth etc.....

Taken from talk: Performance Metrics of Future Light Sources, by Robert Hettel, SLAC, ICXFA Future Light Sources 2010, March 1, 2010 at SLAC:





Properties of the x-ray beam directly depend on the properties of the electron source and the properties of the magnet or insertion device producing the x-rays

The technology depends on the purpose





Speed: Koenigsegg CCX from Sweden. It can go from 0 to 60 mph in 3.2 seconds



Carrying Capacity: Chevy Silverado 2011 ½ Ton Pickup



Comfort & Livability Tiffin 45' RV 2011



Cornell University Cornell High Energy Synchrotron Source

X-rays at the Diffraction Limit, a series of Workshops, June, 2011



Comparison of SR, ERL, XFELs



Flux and Brilliance

Comparison of flux and brilliance between the ESRF and some proposed sources including the UHXS storage ring source, the Cornell Energy Recovery Linac, and X-ray FEL sources based on Self-Amplified Spontaneous Emission (SASE). Part of the data in this table has been taken from the report "ERL_CHESS_memo_01_002.pdf" available from http://erl.chess.cornell.edu/ Papers/Papers.htm

Source	ESRF	UHXS	Cornell	LCLS	TESLA
Туре	Storage Ring	Storage Ring	Storage Ring ERL		SASE FEL
Electron Energy [GeV]	6	7	5.3	15	25
Average Current [mA]	200	500	100	7.20E-5	0.063
Hor. Emittance [nm]	4	0.2	0.15	0.05	0.02
Vert. Emittance [nm]	0.01	0.005	0.15	0.05	0.02
FWHM Bunch Length [ps]	35	13	0.3	0.23	0.09
Undulator Length [m]	5	7	25	100	200
Fundamental [keV]	8	12	8	10	12.4
Average Flux [Ph/s/.1%]	1.3E+15	2.0E+16	1.5E+16	2.4E+14	4.0E+17
Average Brilliance [Ph/s/.1%/mm ² /mrad ²]	3.1E+20	3.5E+22	1.3E+22	4.2E+22	8.0E+25
Peak Brilliance [Ph/s/.1%/mm ² /mrad ²]	3.3E+22	1.0E+25	3.0E+25	1.2E+33	7.0E+33

Pascal Elleaume, "The Ultimate Hard X-Ray Storage-Ring-Based Light Source", SLAC Beamline, 32-1 (2002).

Disclaimer: Though the comparisons are a bit dated, they are probably correct to within an order of magnitude and are highly dependent on how the electron optics are run for all the choices - and linacs have many choices.



Features of New Light Sources



XFELs: extremely high peak-brightness, coherence and 10 fs pulse length with bunch compression

ERL and Ultimate Ring-based Sources:

- 1. High average brightness (fully coherence at 10 keV),
- 2. Lower peak brightness compared to XFELs
- 3. Higher repetition rate
- 4. Wide energy spectrum and ultra-high energy resolution
 - 1 nm-sized x-ray beams
 - 1 meV energy resolution
 - sub-10 ps pulses
 - desire round electron beams for many of the "probe" technologies
- 5. Support many photon beam lines and serves many users simultaneously
- 6. Many improvements are being made in accelerator hardware/software so the state-of-the-art keeps improving! Cross-fertilization of technologies.
- 7. We X-ray community users/developers have an opportunity to ask what new things we can do with new sources and to articulate what could be done if parameter "X" were made "better" or "improved further".



PEP-X Baseline Concept

from Bob Hettel, 5/30/2011

C = 2.2 kmMax stored bunches =3,400 **RF frequency = 476 MHz**

E = 4.5 GeVI = 1.5 A $\varepsilon_x = 150 \text{ pm-rad}$ (~0.06 nm-rad w/o IBS) $\varepsilon_v = 8 \text{ pm-rad}$ $\sigma_s = 3/6 \text{ mm}$ (without/with 3rd harm rf) $\tau = ~1 h$

top-up injection every few seconds (~7 nC, multiple bunches)



- 2 arcs of DBA cells with 32 ID beam
 ~90 m damping wigglers lines (4.3-m straights)
- 4 arcs of TME cells

- 6 ea 120-m straights for injection, RF, damping wigglers long IDs, etc.

Notes on PEP-X Design



Notes on 3-phase PEP-X design study to date (May 2011):

- 1. Phase 1: Baseline design (155 x 8 pm-rad, 1500 mA, 4.5 GeV) complete
- 2. ERL configurations (assuming Cornell parameters) complete
- 3. "Ultimate" lattice (~15 x 15 pm, 150-200 mA, 4.5 GeV) very preliminary

Average spectral brightness approaching 10²³ Short pulses 10 psec (100 fs in occasional single bunches) High coherent fraction at 10 keV High current translates into high flux production



PEP-X Special Operating Modes



Short bunches

- The nominal rms bunch length is 3 mm which would be stretched to ~6 mm rms (20 psec) with a 3rd harmonic cavity in order to improve lifetime and reduce emittance growth due to IBS
- Localized bunch-shortening schemes are possible (e.g. crab cavities or y-z emittance exhange) – ps or less.
- A single short bunch (~100 fs) can be injected into a gap and allowed to circulate once or a few times around the ring. Emittance and bunch length increase as the bunch circulates due to CSR effects.

Lasing

- Studies indicate that a bunch having ~200-300 A pk and an emittance on the order of 20-30 pm-rad will lase at ~ nm in a single pass through a 50-100 m undulator. This peak current might be generated with beam manipulation or with a single injected bunch (see above) and then switched into a bypass to lase. Rep rates could be multi-kHz, limited by kicker rep rate.
- Preliminary studies indicate that partial lasing at a few nm from the unkicked stored beam may be possible. The rep rate would be the bunch frequency.



6. North Arc 0. Injector 1. Linac A	Turnaround (Beamline A) (Beamline B)	Operating Modes	A High Flux	B High Coherence	C - Short	Bunch		
THOMPSON AND THOMPSON	TE VMC	Energy (GeV)	5	5	5			
	A TOPT	Current (mA)	100	25	25	i		
		Bunch Charge (pC)	77	19	19	,		
RETARDER T		Repetition Rate (MHz)	1300	1300	130	0		
	25	Geom. Emittance (pm) h/v	30	8	120/9	11/9		
	J IL	RMS bunch length (fs)	2000	2000	100	1000		
	AD and	Relative energy spread 0.0002		0.0002	0.002			
Cornell ERL 5. CESR 4. South Arc	Average spectral brightness of 10 ²³ Short pulses of 2 ps (50 fs compressed) High coherent fraction at 10 keV Very low electron energy spread which helps long undulator performance							

KEK ERL parameters: average spectral brightness of 10²³, of 10²⁷ in XFELO mode, more numbers on poster



Tickle and Probe 1 (Timing)



photoinduced metallization ~ 1.5ps Collet et al. Science (2005) 307, 86 Taken from Overview of Energy Recovery Linacs, talk by Ryoichi Hijima ERL Development Group, Japan Atomic Energy Agency, on 1/29/07 at Asian Particle Accelerator Conference

Weak photo excitation makes this organic salt material attractive for applications in switching devices with room temperature operation.

Implications for: electron-lattice interactions strongly correlated electron systems

dynamics of material = function of material

Chollet at end of paper "X-ray structural analysis and soft x-ray emission spectroscopy with femtosecond resolution, in addition to theoretical study, will be needed for clarifying the real mechanism of the observed gigantic photoinduced metallization and also will be important for molecular device-oriented research (ref. to Sokolowski-Titan.., Cavalleri.. & Rousse..)"



Tickle and Probe 2: TRXEOL (Time-Resolved X-ray Excited Optical Luminescence)



Idea of T.K. Sham (U of Western Ontario) & collaborators

TRXEOL has been shown to be useful for studying light emitting and electronic properties of nano-materials such as ZnO nanowires, pillars, etc. because it provides element and sometimes chemical specificity as well as access to the energy and time domain of the emission process [1].



Figure.1 Schematic for TRXEOL measurement at storages rings with conventional optics. (a) lifetime, (b) time-gated XEOL, (c) Time resolved XAFS and (d) optical map

[1] T.K. Sham and Richard A. Rosenberg, ChemPhysChem, 8, 2557-2567 (2007).



Cornell University Cornell High Energy Synchrotron Source 50-150 nsec, delayed APS (80 psec pump)

0-10 nsec, prompt

CLS (60 psec pump)

Going to ERL 0.1 ps – 2 ps pump

Measure luminescence decay in the ps to ns range that was not accessible with 3rd generation light sources

Near band-gap emission is too fast to be tracked by present storage ring pulses while the defect emission can reveal the details about energy transfer important for light emitting and electronic properties of nano-materials involved in energy utilization

Continuous Recording of Shock-wave Powder Diffraction Data at a 25 Nanosecond Frame Rate by Don Bilderback



Diffraction Geometry & Intensity Calculation. Incoming X-ray beam of 2.8 x 10 x-rays/second From a 25 meter long undulator One powder grain Period of 1.7 cm, third harmonic at shown schematically Needed: Two-dimensional area detector with 512 x 512 20 keV, ERL at 5 GeV, 100 mA that contributes to the pixel format for angle dispersive powder diffraction that Debye -Scherrer can readout at least a dozen frames with 25 nanosecond diffraction rings. framing rate. Time resolution comes from the detector in this method. 50% absorption 25 nsec # photons in Debye-Scherrer cone = 2.8e15 x-rays/sec*0.1*0.5*5*[0.1/360]*25e-9 = 5000 x-rays in 25 nsec 0.1 degree divergence/360 degrees 10% reflectivity multiplicity

Overview: Shock waves can drive pressures momentarily to higher than center-of-the-earth values. With the ultrahigh monochromatic x-ray flux from an ERL source, continuous recording of angle-dispersive powder diffraction with a 25 nsec frame rate seems feasible if the ERL and a suitable x-ray detector can be achieved.





Confocal x-ray microscope concept with single atom resolution







X-rays at the Diffraction Limit, a series of Workshops, June, 2011



END

